

Notice of References Cited	Application/Control No. 10/722,776	Applicant(s)/Patent Under Reexamination WANG ET AL.	
	Examiner Nancy Bitar	Art Unit 2624	Page 1 of 1

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*	B	US-6,128,410	10-2000	Park et al.	382/218
*	C	US-2004/0071363	04-2004	Kouri et al.	382/276
*	D	US-7,139,739	11-2006	Agrafiotis et al.	706/20
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Clustering Pattern Similarity in Large Data Sets , Wang et al, June 2002
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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